



Features

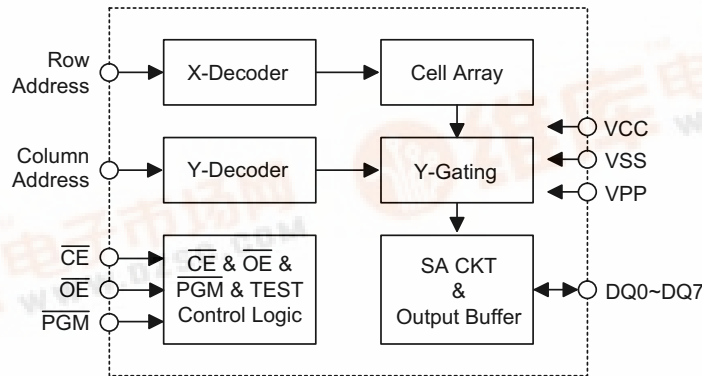
- Operating voltage: +5.0V
- Programming voltage
 - $V_{PP}=12.5V\pm 0.2V$
 - $V_{CC}=6.0V\pm 0.2V$
- High-reliability CMOS technology
- Latch-up immunity to 100mA from -1.0V to $V_{CC}+1.0V$
- CMOS and TTL compatible I/O
- Low power consumption
 - Active: 30mA max.
 - Standby: 1 μ A typ.
- 128K×8-bit organization
- Fast read access time: 70ns
- Fast programming algorithm
- Programming time 75 μ s typ.
- Two line controls (\overline{OE} and \overline{CE})
- Standard product identification code
- Commercial temperature range (0°C to +70°C)
- 32-pin DIP/SOP/PLCC package

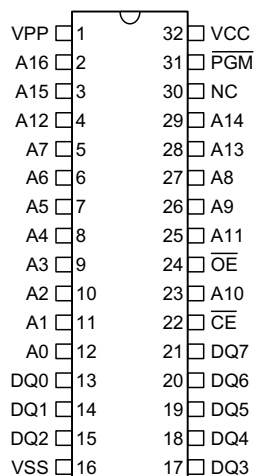
General Description

The HT27C010 chip family is a low-power, 1024K (1,048,576) bit, +5V electrically one-time programmable (OTP) read-only memories (EPROM). Organized into 128K words with 8 bits per word, it features a fast single address location programming, typically at 75 μ s per byte. Any byte can be accessed in less than 70ns with

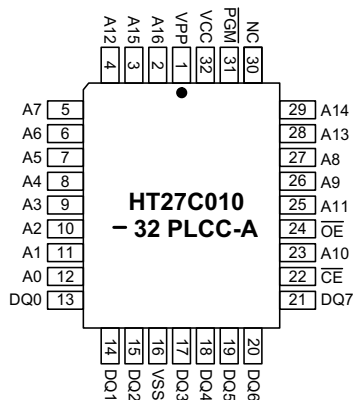
respect to Spec. This eliminates the need for WAIT states in high-performance microprocessor systems. The HT27C010 has separate Output Enable (\overline{OE}) and Chip Enable (\overline{CE}) controls which eliminate bus contention issues.

Block Diagram



Pin Assignment


**HT27C010
- 32 DIP-A/SOP-A**


Pin Description

| Pin Name | I/O/C/P | Description |
|-----------------|---------|-------------------------------|
| A0~A16 | I | Address inputs |
| DQ0~DQ7 | I/O | Data inputs/outputs |
| \overline{CE} | C | Chip enable |
| \overline{OE} | C | Output enable |
| PGM | C | Program strobe |
| NC | — | No connection |
| VPP | P | Program voltage supply |
| VCC | I | Positive power supply |
| VSS | I | Negative power supply, ground |

Absolute Maximum Rating

| | |
|---|------------------------|
| Operation Temperature Commercial | 0°C to +70°C |
| Storage Temperature | -65°C to 125 °C |
| Applied VCC Voltage with Respect to VSS | -0.6V to 7.0V |
| Applied Voltage on Input Pin with Respect to VSS..... | -0.6V to 7.0V |
| Applied Voltage on Output Pin with Respect to VSS | -0.6V to $V_{CC}+0.5V$ |
| Applied Voltage on A9 Pin with Respect to VSS..... | -0.6V to 13.5V |
| Applied VPP Voltage with Respect to VSS..... | -0.6V to 13.5V |
| Applied READ Voltage (Functionality is guaranteed between these limits) | +4.5V to +5.5V |

Note: These are stress ratings only. Stresses exceeding the range specified under "Absolute Maximum Ratings" may cause substantial damage to the device. Functional operation of this device at other conditions beyond those listed in the specification is not implied and prolonged exposure to extreme conditions may affect device reliability.

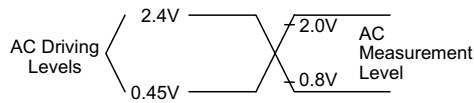
D.C. Characteristics

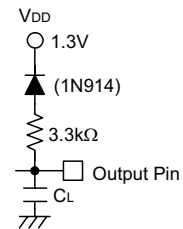
| Symbol | Parameter | Test Conditions | | Min. | Typ. | Max. | Unit |
|------------------------------|--------------------------|-----------------|---|--------------------|------|----------------------|------|
| | | V _{CC} | Conditions | | | | |
| Read operation | | | | | | | |
| V _{OH} | Output High Level | 5V | I _{OH} =-0.4mA | 2.4 | — | — | V |
| V _{OL} | Output Low Level | 5V | I _{OL} =2.1mA | — | — | 0.45 | V |
| V _{IH} | Input High Level | 5V | — | 2.0 | — | V _{CC} +0.5 | V |
| V _{IL} | Input Low Level | 5V | — | -0.3 | — | 0.8 | V |
| I _{LI} | Input Leakage Current | 5V | V _{IN} =0 to 5.5V | -5 | — | 5 | μA |
| I _{LO} | Output Leakage Current | 5V | V _{OUT} =0 to 5.5V | -10 | — | 10 | μA |
| I _{CC} | VCC Active Current | 5V | $\overline{CE}=V_{IL}$, f=5MHz, I _{OUT} =0mA | — | — | 30 | mA |
| I _{SB1} | Standby Current (CMOS) | 5V | $\overline{CE}=V_{CC}\pm 0.3V$ | — | 1.0 | 10 | μA |
| I _{SB2} | Standby Current (TTL) | 5V | $\overline{CE}=V_{IH}$ | — | — | 1.0 | mA |
| I _{PP} | VPP Read/Standby Current | 5V | $\overline{CE}=\overline{OE}=V_{IL}$, V _{PP} =V _{CC} | — | — | 100 | μA |
| Programming operation | | | | | | | |
| V _{OH} | Output High Level | 6V | I _{OH} =-0.4mA | 2.4 | — | — | V |
| V _{OL} | Output Low Level | 6V | I _{OL} =2.1mA | — | — | 0.45 | V |
| V _{IH} | Input High Level | 6V | — | 0.7V _{CC} | — | V _{CC} +0.5 | V |
| V _{IL} | Input Low Level | 6V | — | -0.5 | — | 0.8 | V |
| I _{LI} | Input Load Current | 6V | V _{IN} =V _{IL} , V _{IH} | — | — | 5.0 | μA |
| V _H | A9 Product ID Voltage | 6V | — | 11.5 | — | 12.5 | V |
| I _{CC} | VCC Supply Current | 6V | — | — | — | 40 | mA |
| I _{PP} | VPP Supply Current | 6V | $\overline{CE}=V_{IL}$ | — | — | 10 | mA |
| Capacitance | | | | | | | |
| C _{IN} | Input Capacitance | 5V | V _{IN} =0V | — | 8 | 12 | pF |
| C _{OUT} | Output Capacitance | 5V | V _{OUT} =0V | — | 8 | 12 | pF |
| C _{VPP} | VPP Capacitance | 5V | V _{PP} =0V | — | 18 | 25 | pF |

A.C. Characteristics

Ta=+25°C±5°C

| Symbol | Parameter | Test Conditions | | Min. | Typ. | Max. | Unit |
|------------------------------|---|-----------------|--------------------------------------|------|------|------|------|
| | | V _{CC} | Conditions | | | | |
| Read operation | | | | | | | |
| t _{ACC} | Address to Output Delay | 5V | $\overline{CE}=\overline{OE}=V_{IL}$ | — | | 70 | ns |
| t _{CE} | Chip Enable to Output Delay | 5V | $\overline{OE}=V_{IL}$ | — | | 70 | ns |
| t _{OE} | Output Enable to Output Delay | 5V | $\overline{CE}=V_{IL}$ | — | | 30 | ns |
| t _{DF} | \overline{CE} or \overline{OE} High to Output Float, Whichever Occurred First | 5V | — | — | | 25 | ns |
| t _{OH} | Output Hold from Address, \overline{CE} or \overline{OE} , Whichever Occurred First | 5V | — | 0 | | — | ns |
| Programming operation | | | | | | | |
| t _{AS} | Address Setup Time | 6V | — | 2 | — | — | μs |
| t _{OES} | \overline{OE} Setup Time | 6V | — | 2 | — | — | μs |
| t _{DS} | Data Setup Time | 6V | — | 2 | — | — | μs |
| t _{AH} | Address Hold Time | 6V | — | 0 | — | — | μs |
| t _{DH} | Data Hold Time | 6V | — | 2 | — | — | μs |
| t _{DFP} | Output Enable to Output Float Delay | 6V | — | 0 | — | 130 | ns |
| t _{VPS} | VPP Setup Time | 6V | — | 2 | — | — | μs |
| t _{PW} | PGM Program Pulse Width | 6V | — | 30 | 75 | 105 | μs |
| t _{VCS} | VCC Setup Time | 6V | — | 2 | — | — | μs |
| t _{CES} | \overline{CE} Setup Time | 6V | — | 2 | — | — | μs |
| t _{OE} | Data Valid from \overline{OE} | 6V | — | — | — | 150 | ns |
| t _{PRT} | VPP Pulse Rise Time During Programming | 6V | — | 2 | — | — | μs |

Test waveforms and measurements

 $t_R, t_F < 20\text{ns}$ (10% to 90%)

Output test load

 Note: C_L=100pF including jig capacitance, except for the -45 devices, where C_L=30pF.

Functional Description

Programming of the HT27C010

When the HT27C010 is delivered, the chip has all 1024K bits in the "ONE", or HIGH state. "ZEROS" are loaded into the HT27C010 through programming.

The programming mode is entered when $12.5 \pm 0.2V$ is applied to the VPP pin, OE is at V_{IH} , and CE and PGM are V_{IL} . For programming, the data to be programmed is applied with 8 bits in parallel to the data pins.

The programming flowchart in Figure 3 shows the fast interactive programming algorithm. The interactive algorithm reduces programming time by using $30\mu s$ to $105\mu s$ programming pulses and giving each address only as many pulses as is necessary in order to reliably program the data. After each pulse is applied to a given address, the data in that address is verified. If the data is not verified, additional pulses are given until it is verified or until the maximum number of pulses is reached while sequencing through each address of the HT27C010. This process is repeated while sequencing through each address of the HT27C010. This part of the programming algorithm is done at $V_{CC}=6.0V$ to assure that each EPROM bit is programmed to a sufficiently high threshold voltage. This ensures that all bits have sufficient margin. After the final address is completed, the entire EPROM memory is read at $V_{CC}=V_{PP}=5.25 \pm 0.25V$ to verify the entire memory.

Program inhibit mode

Programming of multiple HT27C010 in parallel with different data is also easily accomplished by using the Program Inhibit Mode. Except for CE, all like inputs of the parallel HT27C010 may be common. A TTL low-level program pulse applied to an HT27C010 CE input with $V_{PP}=12.5 \pm 0.2V$, PGM LOW, and OE HIGH will program that HT27C010. A high-level CE input inhibits the HT27C010 from being programmed.

Program verify mode

Verification should be performed on the programmed bits to determine whether they were correctly programmed. The verification should be performed with OE and CE at V_{IL} , PGM at V_{IH} , and VPP at its programming voltage.

Auto product identification

The Auto Product Identification mode allows the reading out of a binary code from an EPROM that will identify its manufacturer and the type. This mode is intended for programming to automatically match the device to be programmed with its corresponding programming algorithm. This mode is functional in the $25^{\circ}C \pm 5^{\circ}C$ ambient temperature range that is required when programming the HT27C010.

To activate this mode, the programming equipment must force $12.0 \pm 0.5V$ on the address line A9 of the HT27C010. Two identifier bytes may then be sequenced from the device outputs by toggling address line A0 from V_{IL} to V_{IH} , when $A1=V_{IH}$. All other address lines must be held at V_{IH} during Auto Product Identification mode.

Byte 0 ($A0=V_{IL}$) represents the manufacturer code, and byte 1 ($A0=V_{IH}$), the device code. For HT27C010, these two identifier bytes are given in the Operation mode truth table. All identifiers for the manufacturer and device codes will possess odd parity, with the MSB (DQ7) defined as the parity bit. When $A1=V_{IL}$, the HT27C010 will read out the binary code of 7F, continuation code, to signify the unavailability of manufacturer ID codes.

Read mode

The HT27C010 has two control functions, both of which must be logically satisfied in order to obtain data at outputs. Chip Enable (CE) is the power control and should be used for device selection. Output Enable (OE) is the output control and should be used to gate data to the output pins, independent of device selection. Assuming that addresses are stable, address access time (t_{ACC}) is equal to the delay from CE to output (t_{CE}). Data is available at the outputs (t_{OE}) after the falling edge of OE, assuming the CE has been LOW and addresses have been stable for at least $t_{ACC}-t_{OE}$.

Standby mode

The HT27C010 has CMOS standby mode which reduces the maximum VCC current to $10\mu A$. It is placed in CMOS standby when CE is at $V_{CC} \pm 0.3V$. The HT27C010 also has a TTL-standby mode which reduces the maximum VCC current to 1.0mA. It is placed in TTL-standby when CE is at V_{IH} . When in standby mode, the outputs are in a high-impedance state, independent of the OE input.

Two-line output control function

To accommodate multiple memory connections, a two-line control function is provided to allow for:

- Low memory power dissipation
- Assurance that output bus contention will not occur

It is recommended that CE be decoded and used as the primary device-selection function, while OE be made a common connection to the READ line from the system control bus. This assures that all deselected memory devices are in their low-power standby mode and that the output pins are only active when data is desired from a particular memory device.

System considerations

During the switch between active and standby conditions, transient current peaks are produced on the rising and falling edges of Chip Enable. The magnitude of these transient current peaks is dependent on the output capacitance loading of the device. At a minimum, a 0.1 μ F ceramic capacitor (high frequency, low inherent inductance) should be used on each device between

VCC and VPP to minimize transient effects. In addition, to overcome the voltage drop caused by the inductive effects of the printed circuit board traces on EPROM arrays, a 4.7 μ F bulk electrolytic capacitor should be used between VCC and VPP for each eight devices. The location of the capacitor should be close to where the power supply is connected to the array.

Operation mode truth table

All the operation modes are shown in the table following.

| Mode | \overline{CE} | \overline{OE} | PGM | A0 | A1 | A9 | VPP | Output |
|-----------------------|-----------------------|-----------------|-----------------|-----------------|-----------------|--------------------|-----------------|------------------|
| Read | V _{IL} | V _{IL} | X (2) | X | X | X | V _{CC} | Dout |
| Output Disable | V _{IL} | V _{IH} | X | X | X | X | V _{CC} | High Z |
| Standby (TTL) | V _{IH} | X | X | X | X | X | V _{CC} | High Z |
| Standby (CMOS) | V _{CC} ±0.3V | X | X | X | X | X | V _{CC} | High Z |
| Program | V _{IL} | V _{IH} | V _{IL} | X | X | X | V _{PP} | D _{IN} |
| Program Verify | V _{IL} | V _{IL} | V _{IH} | X | X | X | V _{PP} | D _{OUT} |
| Product Inhibit | V _{IH} | X | X | X | X | X | V _{PP} | High Z |
| Manufacturer Code (3) | V _{IL} | V _{IL} | X | V _{IL} | V _{IH} | V _H (1) | V _{CC} | 1C |
| Device Type Code (3) | V _{IL} | V _{IL} | X | V _{IH} | V _{IH} | V _H (1) | V _{CC} | 01 |

Note: (1) V_H=12.0V ± 0.5V

(2) X=Either V_{IH} or V_{IL}

(3) For Manufacturer Code and Device Code, A1=V_{IH}, When A1=V_{IL}, both codes will read 7F

Product Identification Code

| Code | Pins | | | | | | | | | | Hex Data |
|--------------|------|----|-----|-----|-----|-----|-----|-----|-----|-----|----------|
| | A0 | A1 | DQ7 | DQ6 | DQ5 | DQ4 | DQ3 | DQ2 | DQ1 | DQ0 | |
| Manufacturer | 0 | 1 | 0 | 0 | 0 | 1 | 1 | 1 | 0 | 0 | 1C |
| Device Type | 1 | 1 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 01 |
| Continuation | 0 | 0 | 0 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 7F |
| | 1 | 0 | 0 | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 7F |

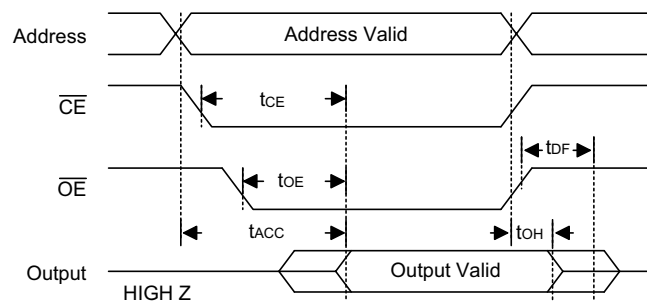


Figure 1. A.C. waveforms for read operation

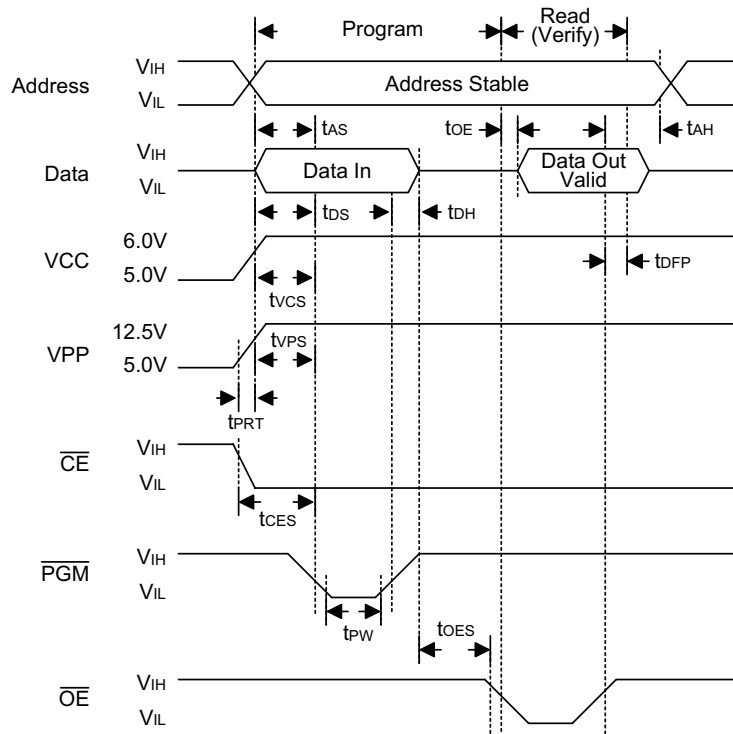
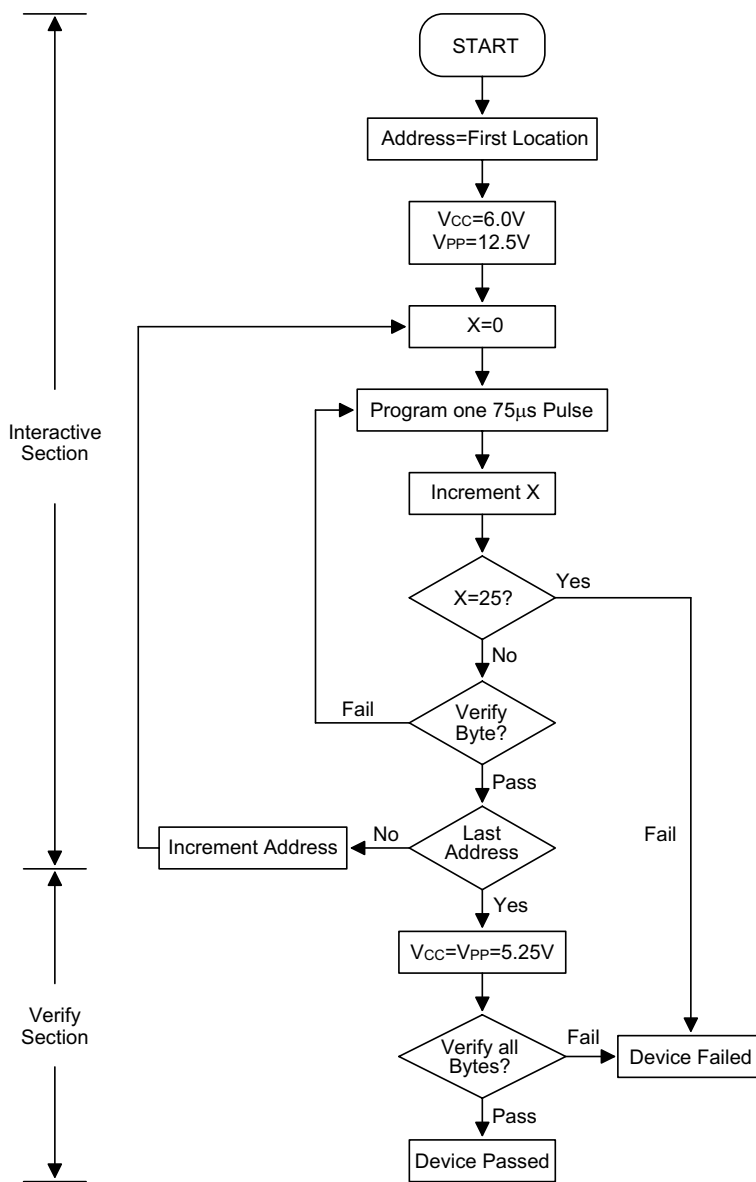


Figure 2. Programming waveforms

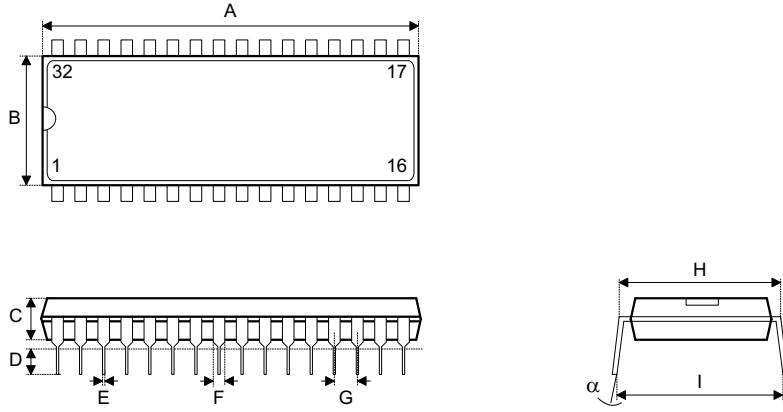


Note: Either 105µs or 30µs pulse.

Figure 3. Fast programming flowchart

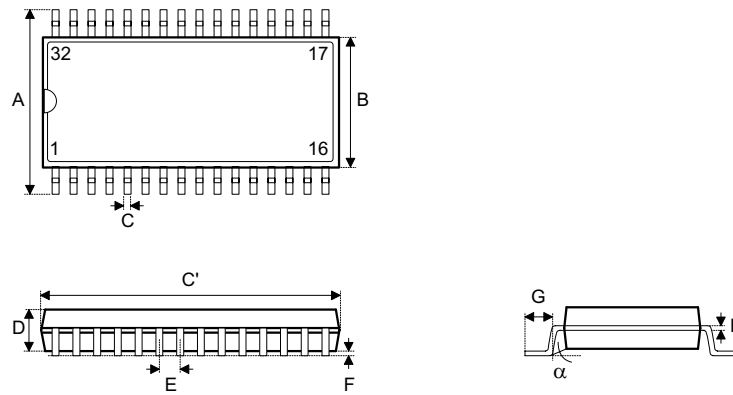
Package Information

32-pin DIP (600mil) outline dimensions



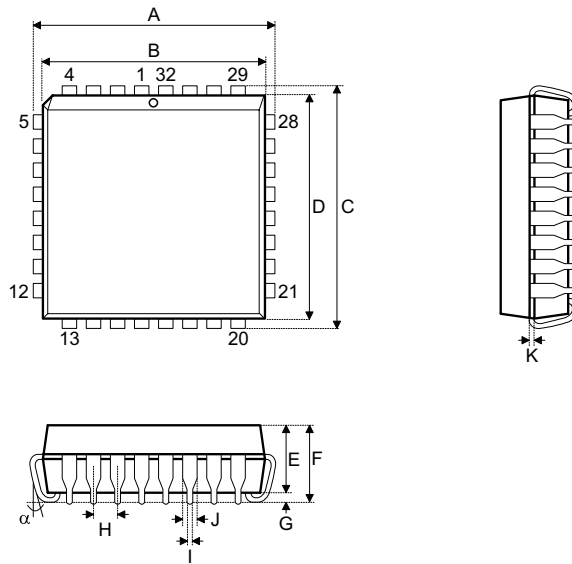
| Symbol | Dimensions in mil | | |
|----------|-------------------|------|------|
| | Min. | Nom. | Max. |
| A | 1635 | — | 1665 |
| B | 535 | — | 555 |
| C | 145 | — | 155 |
| D | 125 | — | 145 |
| E | 16 | — | 20 |
| F | 50 | — | 70 |
| G | — | 100 | — |
| H | 595 | — | 615 |
| I | 635 | — | 670 |
| α | 0° | — | 15° |

32-pin SOP (450mil) outline dimensions

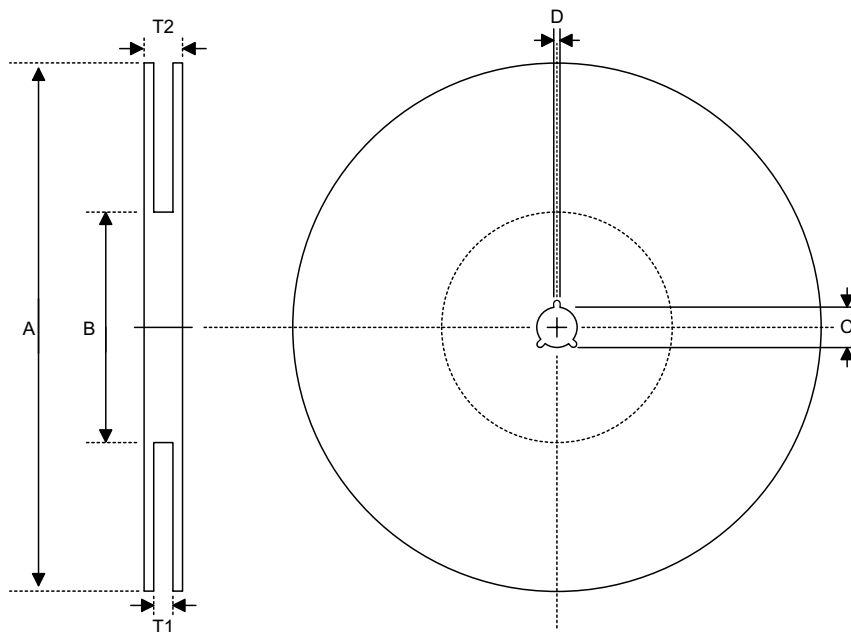


| Symbol | Dimensions in mil | | |
|----------|-------------------|------|------|
| | Min. | Nom. | Max. |
| A | 543 | — | 557 |
| B | 440 | — | 450 |
| C | 14 | — | 20 |
| C' | — | — | 817 |
| D | 100 | — | 112 |
| E | — | 50 | — |
| F | 4 | — | — |
| G | 32 | — | 38 |
| H | 4 | — | 12 |
| α | 0° | — | 10° |

32-pin PLCC outline dimensions



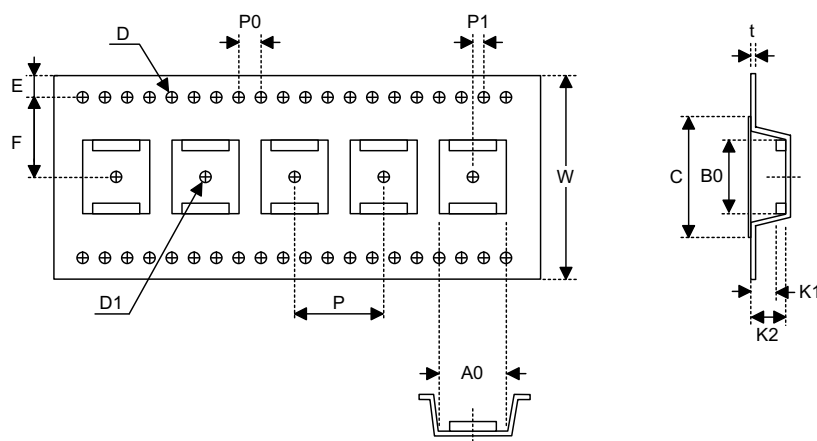
| Symbol | Dimensions in mil | | |
|----------|-------------------|------|------|
| | Min. | Nom. | Max. |
| A | 485 | — | 495 |
| B | 445 | — | 455 |
| C | 585 | — | 595 |
| D | 545 | — | 555 |
| E | 105 | — | 115 |
| F | — | — | 140 |
| G | 15 | — | — |
| H | — | 50 | — |
| I | 16 | — | 22 |
| J | 24 | — | 32 |
| K | 8 | — | 12 |
| α | 0° | — | 10° |

Product Tape and Reel Specifications
Reel dimensions

SOP 32W

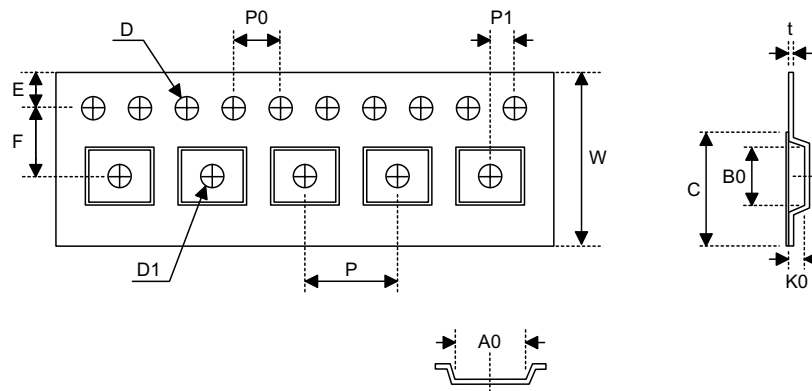
| Symbol | Description | Dimensions in mm |
|--------|-----------------------|------------------|
| A | Reel Outer Diameter | 330±1.0 |
| B | Reel Inner Diameter | 100±0.1 |
| C | Spindle Hole Diameter | 13.0+0.5 -0.2 |
| D | Key Slit Width | 2.0±0.5 |
| T1 | Space Between Flange | 32.8+0.3 -0.2 |
| T2 | Reel Thickness | 38.2±0.2 |

PLCC 32

| Symbol | Description | Dimensions in mm |
|--------|-----------------------|------------------|
| A | Reel Outer Diameter | 330±1.0 |
| B | Reel Inner Diameter | 62±1.5 |
| C | Spindle Hole Diameter | 13.0+0.5 -0.2 |
| D | Key Slit Width | 2.0±0.5 |
| T1 | Space Between Flange | 24.8+0.3 -0.2 |
| T2 | Reel Thickness | 30.2±0.2 |

Carrier tape dimensions

SOP 32W

| Symbol | Description | Dimensions in mm |
|--------|--|------------------|
| W | Carrier Tape Width | 32.0+0.3 -0.1 |
| P | Cavity Pitch | 16.0±0.1 |
| E | Perforation Position | 1.75±0.1 |
| F | Cavity to Perforation (Width Direction) | 14.2±0.1 |
| D | Perforation Diameter | 1.55+0.1 |
| D1 | Cavity Hole Diameter | 2.0+0.25 |
| P0 | Perforation Pitch | 4.0±0.1 |
| P1 | Cavity to Perforation (Length Direction) | 2.0±0.1 |
| A0 | Cavity Length | 14.7±0.1 |
| B0 | Cavity Width | 20.9±0.1 |
| K1 | Cavity Depth | 3.0±0.1 |
| K2 | Cavity Depth | 3.4±0.1 |
| t | Carrier Tape Thickness | 0.35±0.05 |
| C | Cover Tape Width | 25.5 |



PLCC 32

| Symbol | Description | Dimensions in mm |
|--------|--|-------------------|
| W | Carrier Tape Width | 24.0±0.3 |
| P | Cavity Pitch | 18.0±0.1 |
| E | Perforation Position | 1.75±0.1 |
| F | Cavity to Perforation (Width Direction) | 11.5±0.1 |
| D | Perforation Diameter | 1.5±0.1 |
| D1 | Cavity Hole Diameter | 1.55+1.0 -0.05 |
| P0 | Perforation Pitch | 4.0±0.1 |
| P1 | Cavity to Perforation (Length Direction) | 2.0±0.1 |
| A0 | Cavity Length | 13.1±0.1 |
| B0 | Cavity Width | 15.5±0.1 |
| K0 | Cavity Depth | 3.9±0.1 |
| t | Carrier Tape Thickness | 0.30±0.05 |
| C | Cover Tape Width | 21.3 |

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